

<b>Notice of References Cited</b>	Application/Control No. 10/692,405	Applicant(s)/Patent Under Reexamination PRATT, DANIEL F.	
	Examiner Matthew J. Song	Art Unit 1722	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0029738	03-2002	Takanashi et al.	117/217
	B	US-5,582,642	12-1996	Korb et al.	117/218
	C	US-5,584,930	12-1996	Katsuoka et al.	117/14
	D	US-5,725,661	03-1998	Fusegawa et al.	117/202
	E	US-5,746,828	05-1998	Boulaev, Anatoli S.	117/201
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06183874 A	07-1994	Japan	HIGO, SHINJI	C30B 15/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Patent Abstracts of Japan. English Abstract and Computer Translation of JP 06-183874 (1994).
	V	IBM Technical Disclosure Bulletin, "Monitoring Diameter Variation and Diameter Control Using Laser Beam and Image Processing in Czochralski Crystal Growth", March 1985, Vol 27, Issue 10A, pp 5777-5778.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.